



LUCKI CM ELECTRONICS Co.,Ltd

APPROVAL SHEET

Customer : _____

Part Number: _____

LK Part No.: L32AOC025000PB

Holder : 3225 OSC

Frequency: 25.000MHz 3.3V

Manufacturer: Lucki Electronics

Date: 2023-04-12

Prepared	Checked	Approved
Zhao Qian	Zhang Dongwei	Zhang Bin

(For Customer Use)

Acceptable	



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● ELECTRICAL PARAMETERS

No.	Item	Symb.	Electrical Specification				Remark
			Min.	Typ.	Max.	Units	
1	Nominal Frequency	F0	25.000000			MHz	
2	Frequency Stability		-30		30	ppm	All condition*
3	Operating Temperature Range	TOPR	-40		85	°C	-40°C~85°C±20ppm
4	Storage Temperature	TSTG	-55		125	°C	
5	Power supply Voltage	V _{DD}	3.3±10%			V	
6	Aging Per Year	Fa	-3.0		3.0	ppm	First Year
7	Supply current	I _{DD}			10	mA	
8	Output symmetry	Sym	45		55	%	
9	Rise time	Tr			5.0	ns	10%~90%V _{DD}
10	Fall time	Tf			5.0	ns	90%~10%V _{DD}
11	Output voltage	V _{OH}	90%			V _{DD}	
		V _{OL}			10%	V _{DD}	
12	Output load Hcmos Load				15	pF	
13	Start-up time				10	mS	
14	Pin 1, E/D function	pin 1="High "or "open"output active at pin 3 pin 1="Low"high impedance at pin 3 pin 1="Low"&Floating unstable at pin3,disallowed for this status					
15	Package type	POSC3225					

NOTE: Storage Temperature is only for the product itself,the temperature for the packing material is -4~40°C.

All condition*: Include 25°C tolerance, operating temperature range , input voltage change, aging, load change.

● STORAGE REQUIRMENT

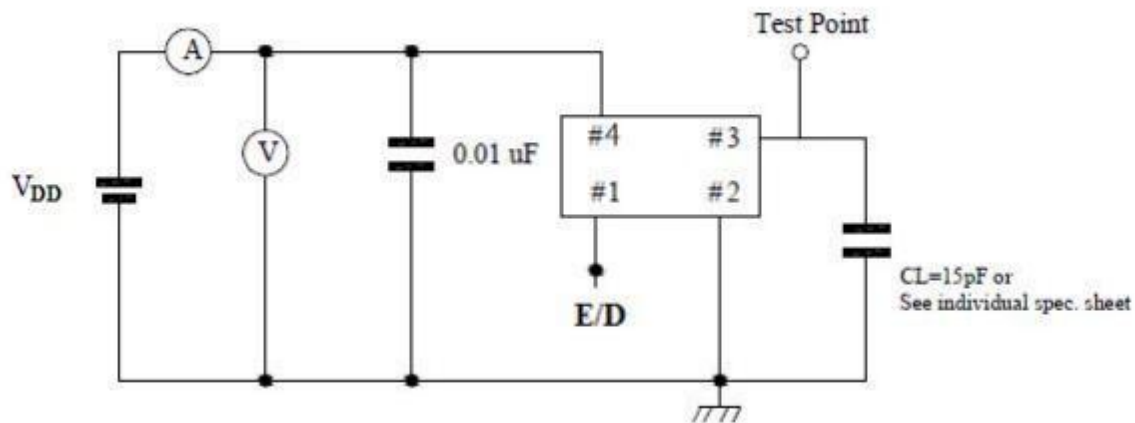
Storage environmental conditions: -4~40°C, 70%RH max.

Maximum storage time: 24 Months from date of manufacture.



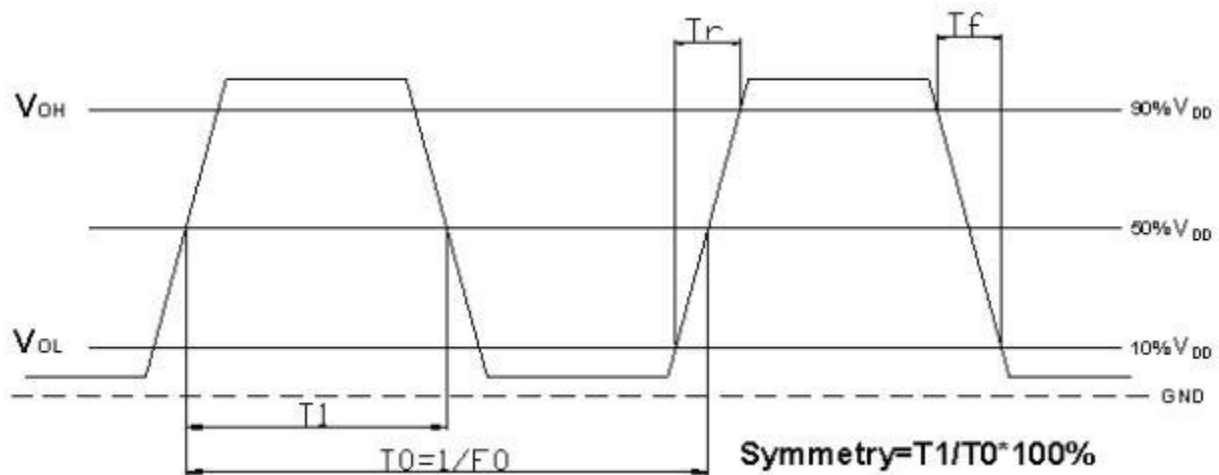
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● HCMOS Test Circuit



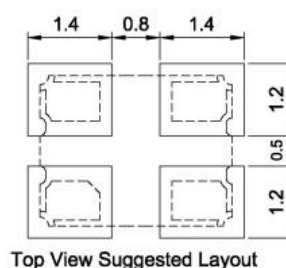
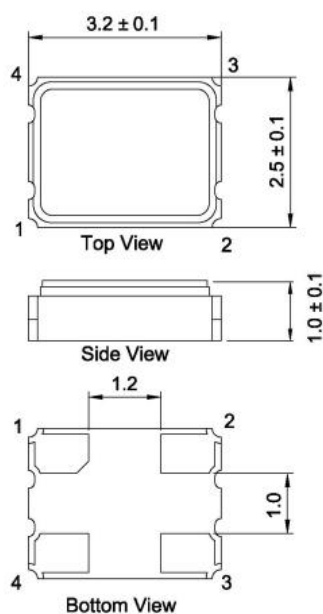
Enable/ Disable Function		
Input (pin 1)	Output (pin 3)	Oscillator
Open	Enable	Normal operation
$V_{IH} : 0.7 \cdot V_{DD} \sim V_{DD}$	Enable	Normal operation
$V_{IL} : 0\text{V} \sim 0.3 \cdot V_{DD}$	Disable	Stop oscillation

HCMOS OUTPUT WAVEFORM



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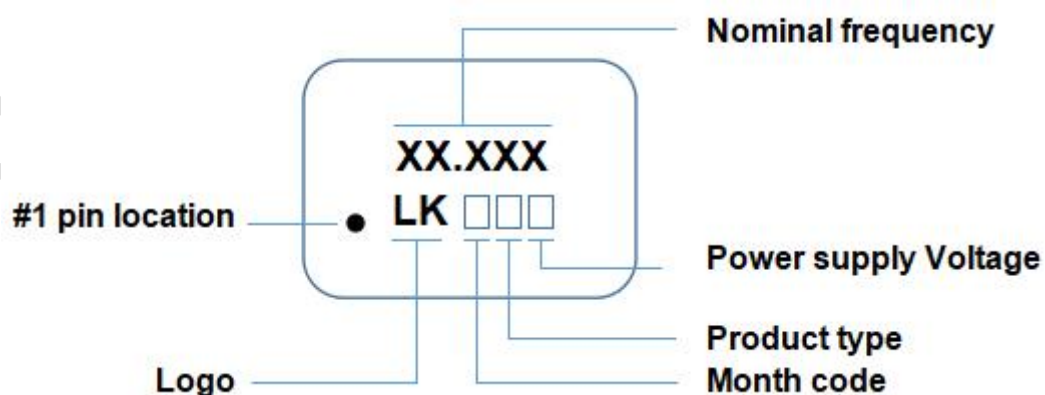
● OUTLINE DIMENSIONS (unit: mm)



Pin	Connection
1	E/D
2	GND
3	Output
4	V _{DD}

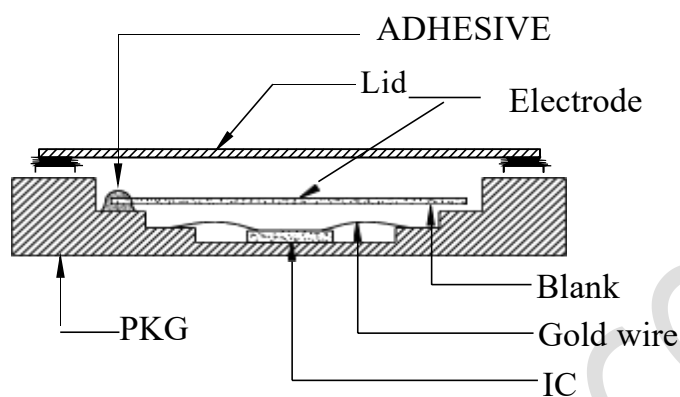
- Note:
- 0.01uF bypass capacitor should be placed between V_{DD} (pin 4) and GND (pin 2) to minimize power supply line noise;
 - Line shouldn't be layed under the oscillator in the PCB to minimize signal interference.
 - The Load we advise is only 15pF (that means drive only 1 CMOS/TTL gate).
 - unlabeled tolerance: $\pm 0.1\text{mm}$

● MARKING



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● PRODUCT LAYOUT



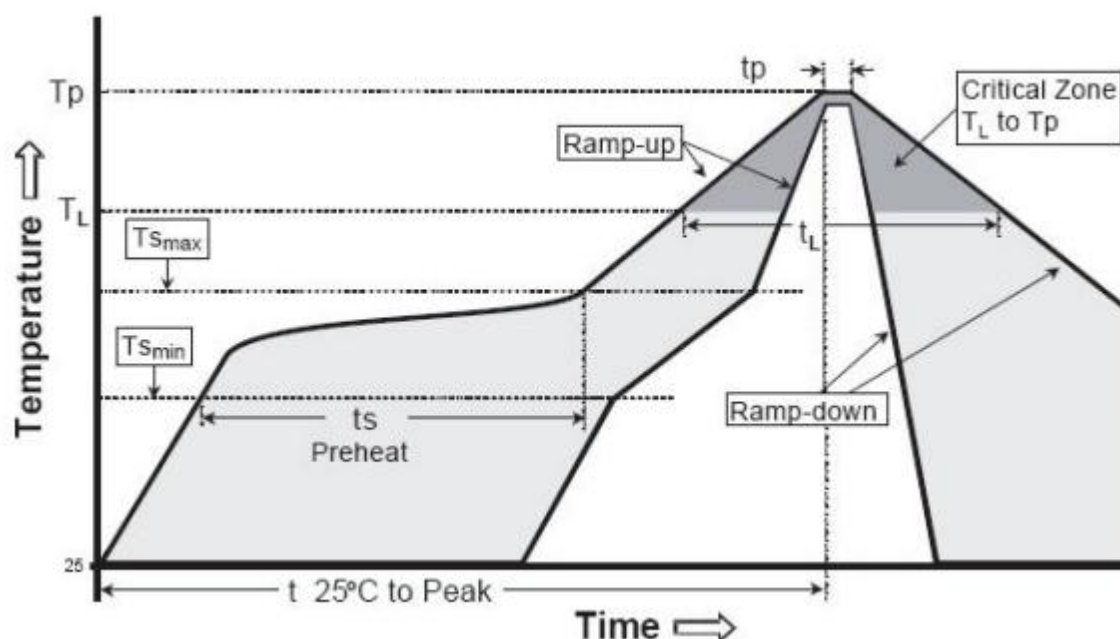
NO.	PART	MATERIAL	REMARK
1	LID	KOVAR(Fe+Co+Ni alloy)	
2	PKG	Al ₂ O ₃	Base
3	BLANK	SiO ₂	Quartz
4	ADHESIVE	Ag/Silicon	Support
5	Electrode	Noble metal	
6	IC	Si	
7	Gold wire	Au	Connect



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● REFLOW PROFILES

Profiles Feature	Pb-Free Assembly
Average Ramp-up Rate (Ts max to Tp)	3 °C/second max.
Preheat ■ Temperature Min (Ts min) ■ Temperature Max (Ts max) ■ Time (ts min to ts max)	125°C 200°C 60~180 seconds
Time maintained above ■ Temperature (T_L) ■ Time (t_L)	217°C 60~150 seconds
Peak/Classification Temperature (Tp)	260°C
Time within 5 °C of actual Peak Temperature (t _p)	20~40 seconds
Ramp-down rate	6 °C/second max.
Time 25°C to Peak Temperature	8 minutes max.
Suggest reflow times	3 Times max



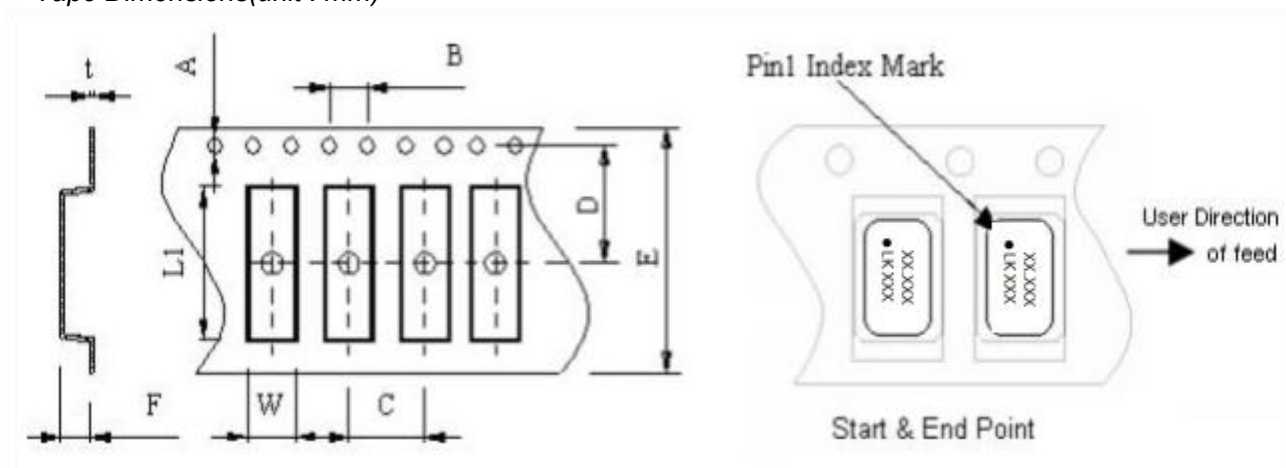
Remark: To reference JEDEC J-STD-020



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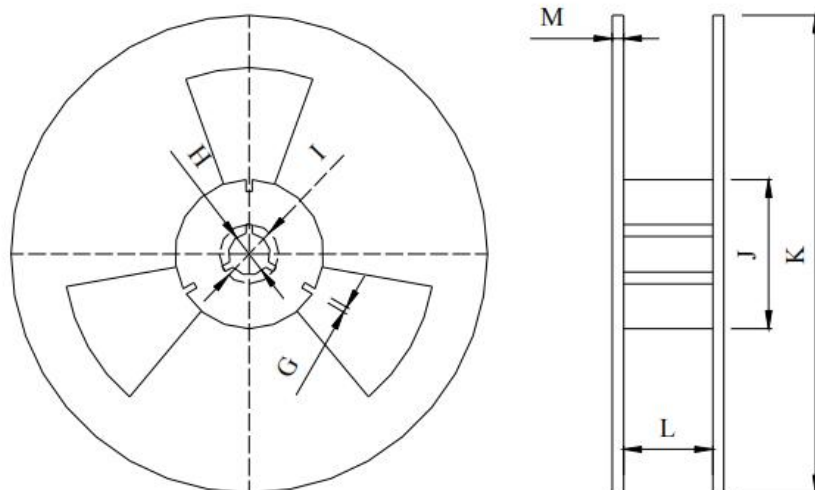
● PACKAGE(reference to EIA-481)

Tape Dimensions(unit : mm)



A	B	C	D	E	F	L1	W	t
1.5±0.1	4.0±0.1	4.0±0.1	3.5±0.1	8.0±0.1	1.4±0.10	3.5±0.10	2.7±0.10	0.25±0.05

Reel Dimensions(unit: mm)



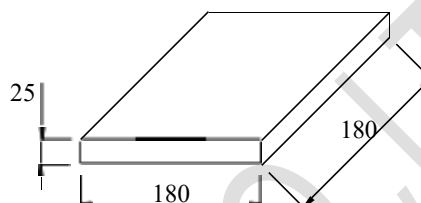
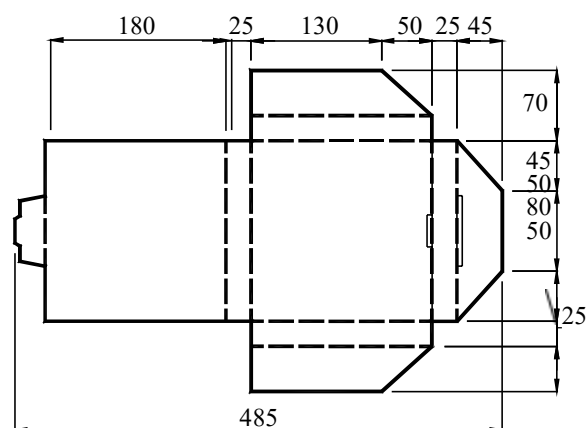
G	H	I	J	K	L	M
2.2±0.5	13.5±0.5	18.2±0.5	60.0± 1.0	178.0± 1.0	9.5± 1.0	1.6±0.2

*3000pcs/Reel

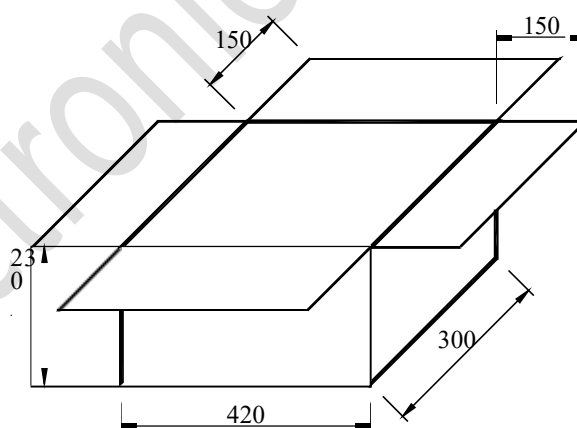
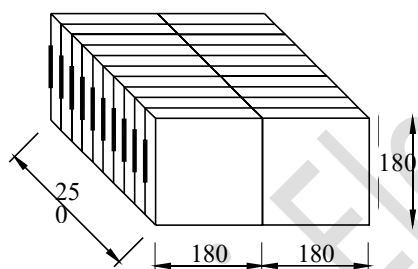


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Carton Dimension (unit : mm)



1 reel = 1 Inner box



20 Inner boxes = 1 Carton, 60kpcs = 1 Carton



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● Reliability characteristic:

No.	Test Item	Test Conditions	Specifications
1	Solderability	Solder bath temperature:260℃ , dwell time:5 seconds, Solder: 100% tin	A new uniform coating of solder shall cover a minimum of 95% of the surface being immersed.
2	Resistance to soldering heat	Solder temperature 260+/-3℃,Immersion time:10 S Solder bath composition:100% tin	$\Delta F \leq \pm 5 \text{ ppm}$
3	Vibration	The entire frequency range: 10Hz to 55Hz ,Amplitude:1.5mm This motion shall be applied for a period of 2 h in each of 3 mutually perpendicular axes(a total of 6h)	$\Delta F \leq \pm 5 \text{ ppm}$
4	Drop test	3 Times Free Fall from 100cm height to concrete floor.	$\Delta F \leq \pm 5 \text{ ppm}$
5	Cold Storage	The quartz crystal unit shall be stored at a temperature of -40+/-3℃ for 1000 h.then it shall be subjected to standard atmospheric conditions for 1h after which measurement shall be made.	$\Delta F \leq \pm 5 \text{ ppm}$
6	High temperature high humidity storage (steady state)	The quartz crystal unit shall be stored at a temperature of 40+/-2℃ with relative humidity of 95% for 1000h, then it shall be subjected to standard atmospheric conditions for 2h after which measurement shall be made.	$\Delta F \leq \pm 5 \text{ ppm}$
7	Thermal Shock	Temperature 1: -55℃ ± 3℃ Temperature 2: 125℃ ± 3℃ Temperature change between T1 and T2 at soonest Run 1000 cycles, maintain T1 and T2 5minutes each in one cycle	$\Delta F \leq \pm 5 \text{ ppm}$
8	Sealing	Helium leakage detector shall used to measure the leakage rate of gas through any faulty seal. Pressure:500Kpa, duration:120 minutes .	Leakage rates $\leq 1 \times 10^{-9} \text{ Pa.m}^3/\text{S}$
9	High temperature Life test	The quartz crystal unit shall be stored at a temperature of 105+/-3℃ for 168h ,then it shall be subjected to standard atmospheric condition for 1h after which measurement shall be made.	$\Delta F \leq \pm 5 \text{ ppm}$